Common Origin of the Circular-dichroism Pattern in ARPES of SrTiO$_3$ and Cu$_x$Bi$_2$Se$_3$

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Abstract

We investigate circular dichroism in the angular distribution (CDAD) of photoelectrons from SrTiO$_3$:Nb and Cu$_x$Bi$_2$Se$_3$ recorded by 7-eV laser ARPES. In addition to the well-known node that occurs in CDAD when the incidence plane matches the mirror plane of the crystal, we show that another type of node occurs when the mirror plane of the crystal is vertical to the incidence plane and the electronic state is two dimensional. The flower-shaped CDAD’s occurring around the Fermi level of SrTiO$_3$:Nb and around the Dirac point of Cu$_x$Bi$_2$Se$_3$ are explained on equal footings. A surface-state-to-surface-resonance transition is indicated for the topological state of Cu$_x$Bi$_2$Se$_3$.

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The interaction of light with matter depends on the polarization of the photons. Circular dichroism (CD) is a phenomenon in which the response of a system to left and right circularly polarized light is different. CD can be microscopically attributed to the difference in the material’s response against opposite helicities of the photons. Thus, CD has been actively used for studying magnetic materials or those having strong spin-orbit interactions [1–3]. Alternatively, left and right circular polarizations are exchanged by a mirror operation, and therefore CD is active when the measurement breaks symmetry with respect to the reflection, i.e., CD occurs when the experimental geometry has “handedness” [4, 5].

In angle resolved photoemission spectroscopy (ARPES), light is shined on a crystal and the energy-and-angle distribution of the photoelectrons is recorded. The band structures of crystals and crystal surfaces are traced by ARPES, and the information is further enriched by investigating the CD in the angular distribution (CDAD) of the photoelectrons [3–12]. For example, a node in CDAD occurs when the incidence plane and the mirror plane of the crystal are matched [5]. This vertical node, which occurs due to reasons of symmetry, has been utilized in various ARPES studies [7–12]. We show herein that there is another type of node in CDAD which occurs due to a combination of the symmetry and dimensionality of the initial electronic state. We find that the CDAD’s of both SrTiO$_3$:Nb around the Fermi level $E_F$ and Cu$_x$Bi$_2$Se$_3$ around the Dirac point $E_D$ exhibit a similar pattern having a horizontal node in addition to the vertical node. The objective of this paper is to determine the origin of the horizontal node and derive information from it. First we investigate photoemission matrix elements and derive the condition for the occurrence of the horizontal node; then we discuss the CDAD’s of SrTiO$_3$:Nb and Cu$_x$Bi$_2$Se$_3$.

In our experimental geometry (Fig. 1), the 7-eV laser impinges the sample with an angle of 45° from the analyzer axis. The sample rotation axis and the direction of the analyzer slit are perpendicular to the plane containing the laser beam and the analyzer axis, so that this plane becomes a mirror plane of the apparatus. Using an orthogonal basis fixed on the sample (we take $e_x$ along the rotation axis and $e_y$ along the sample surface), the vector potentials for right ($A^+$) and left ($A^-$) circular polarizations are described as $A^\pm = A^\pm_{pes} e^{-i(\omega t + \varphi)} + \text{c.c.}$, where $A^\pm_{pes} = \frac{A}{2}(-1, \mp i \cos \eta, \mp i \sin \eta)$, $\eta$ is the angle between the laser beam and $e_z$, and $\varphi$ is a phase. The analyzer collects photoelectrons emitted within the acceptance angle $|\alpha| < 18^\circ$ ($\alpha = 0^\circ$ is the direction to the analyzer axis). The energy-and-angular distribution of the photoelectrons ($I$) is recorded as functions of $\theta$, $\alpha$, and $E_B$, where $\theta$ is the rotation angle of
$e_z$ with respect to the analyzer axis, and $E_B$ is the binding energy referenced to $E_F$ of gold in electrical contact with the sample and the analyzer. The spectra are recorded at 10 K with an energy resolution of $\sim 3$ meV.

In general, a photoemission event from a given initial-to-final state ($|\Psi_i\rangle$ to $|\Psi_f\rangle$) under a given experimental setup has the same cross section to another event which is a mirror reflection of the original one [14]. Here, everything should be reflected, not just the crystal and the incident light, but also $|\Psi_{i,f}\rangle$ into $|\tilde{\Psi}_{i,f}\rangle \equiv \hat{\Pi}|\Psi_{i,f}\rangle$, and even the direction of the circulating currents responsible for magnetism, if any. We consider a one-step photoemission process, so that the final state herein is an inverse low-energy electron diffraction (LEED) state extending from the sample into the detector [5]. One can regard that a pair of $I$ and $\tilde{I}$ obtained in the original and mirror-reflected experiments, respectively, forms a representation of the group $C_s = \{\hat{\Pi}^2, \hat{\Pi}\}$.

Hereafter, let us evaluate the operator under a dipole approximation: $I^\pm \propto |\langle \Psi_f | A_{pes}^\pm \cdot \vec{p} | \Psi_i \rangle|^2$.

When the incidence plane matches the mirror plane of the crystal, the result $\tilde{I}^+$ obtained in a reflected experiment with respect to the incidence plane (this coincides with the apparatus' mirror plane in our experimental geometry) is the same as that of the original experiment with a reversed circular polarization $I^-$, as can be seen by comparing Figs. 2(a1) and 2(a2). Therefore, the pair $\{I^+, I^-\} = \{I^+, \tilde{I}^+\}$ becomes a representation of $C_s$. One can confirm that $|\langle \Psi_f | A_{pes}^+ \cdot \vec{p} | \Psi_i \rangle|^2 = |\langle \tilde{\Psi}_f | A_{pes}^- \cdot \vec{p} | \tilde{\Psi}_i \rangle|^2$ [the left and right hand side of this equation corresponds to the photoemission events shown in Fig. 2(a1) and (a2), respectively] with the aid of $\hat{\Pi}_x(A_{pes}^+ \cdot \vec{p})\hat{\Pi}_x = A_{pes}^+ (-\vec{p}_x e_x + \vec{p}_y e_y + \vec{p}_z e_z) = \frac{1}{2}(1, -i \cos \eta, -i \sin \eta) \cdot \vec{p} = -A_{pes}^- \cdot \vec{p}$. Therefore $I^+(\theta, \alpha, E_B) = I^-(-\theta, -\alpha, E_B)$ in our experimental geometry. Thus, the angular distribution of the dichroism $I^D = I^+ - I^-$ acquires a vertical node, i.e. $I^D(\theta, 0^\circ, E_B) = 0$.

Next, we consider a case where the mirror plane of the crystal is vertical to the incidence plane, and ask whether

$$I^+(\theta, \alpha, E_B) = I^-(-\theta, \alpha, E_B)$$

(1)

can hold. This corresponds to investigating whether the matrix elements for the events shown in Figs. 2(a1) and 2(b) can be equivalent or not. The incidence angles are different, since the laser and the analyzer are fixed in space, thus these two photoemission events cannot overlap by any symmetry operations. Therefore eq. (1) does not hold globally. Nevertheless,
the events shown in Figs. 2(a3) and 2(b) [the former is a reflection of Fig. 2(a1) with respect to the \(zx\) mirror plane, and hence, equivalent to the event of Fig. 2(a1)] resemble each other: in both cases, the initial and final states are the same, and the in-plane \((xy)\) components of \(A\) rotate anti-clockwise on the sample surface. Explicitly, eq. (1) is equivalent to

\[
|\langle \Psi_f^{y} | \hat{\Psi}_i^{y} \rangle | = |\langle \Psi_f^{y} | \hat{\Psi}_i^{y} \rangle | = |\langle \Psi_f^{y} \hat{p}_z | \Psi_i^{y} \rangle | = |\langle \Psi_f^{y} \hat{p}_{x,y} | \Psi_i^{y} \rangle |,
\]

(2)

and the main difference occurs in the sign (phase) of the \(z\) component of the vector potential with respect to the \(x\) and \(y\) components. Thus, when

\[
|\langle \Psi_f | \hat{p}_z | \Psi_i \rangle | \ll |\langle \Psi_f | \hat{p}_{x,y} | \Psi_i \rangle |
\]

(3)
is fulfilled, eq. (2) and hence eq. (1) holds in the vicinity of \(\theta = 0^\circ\), and a horizontal node occurs in the dichroism \(I_{D}(0^\circ, \alpha, E_B) = 0\).

The condition (3) is fulfilled when \(\Psi_i\) is two-dimensional (2D) and spatially confined in the \(z\) direction within a length scale \(a\) shorter than the de Broglie wave length \(\lambda\) of the photoelectron final state, as shown in Fig. 3. Then, \(\int_{-a}^{a} dz \Psi_f^*(x, y, z) \frac{\partial}{\partial z} \Psi_i(x, y, z) \sim \Psi_f^*(x, y, 0) \int_{-a}^{a} dz \frac{\partial}{\partial z} \Psi_i(x, y, z) = 0\), so that the photoemission matrix element becomes susceptible only to the in-plane component of the vector potential. The small photoelectron kinetic energy \(E_{kin}\) achieved by the 7-eV laser is favorable for fulfilling condition (3), since \(\lambda[\text{Å}] \sim 12/\sqrt{E_{kin}}[\text{eV}]\). Even when \(\lambda\) becomes comparable to \(a\), \(\Psi_i(z)\) is usually an oscillating function for \(|z| \lesssim a\), and therefore, the matrix element has little dependence on the \(\hat{p}_z\) component.

The case for \(\text{SrTiO}_3: \text{Nb}\): \(\text{SrTiO}_3\) is an oxide semiconductor having a cubic perovskite structure. The bulk can be doped with carriers by incorporating Nb. Recently, it has been revealed that an inversion layer occurs at the surface of semiconducting \(\text{SrTiO}_3\) independent of the carrier concentration of the bulk [15, 16].

We find that the 2D electron gas formed in the inversion layer of \(\text{SrTiO}_3\) is an ideal case that exhibits CDAD with the horizontal node as well as the vertical node. In Fig. 4, we
show the angular distribution of the spectral weight near $E_F$ recorded on a (001) surface of 1%-Nb-doped SrTiO$_3$ annealed in vacuum for 40 min at 550°C. Here, [100] and [010] are aligned to $e_x$ and $e_y$ within 5°. One can see in $I^+ + I^-$ (a) that the 7-eV laser detects a circular Fermi surface, and when recorded by right (b) and left (c) circular polarizations, the mappings become anisotropic. $I^+$ appears to be a reflection of $I^-$ about the $\theta$ axis and the $\alpha$ axis. As discussed previously, the latter can be understood as a result of the (100) mirror plane matching the incidence plane; the former can be understood from the facts that the (010) mirror plane is vertical to the incidence plane, and the electronic state is 2D. Thus, the dichroism shown in (d) shows both the horizontal and vertical nodes. The normalized dichroic asymmetry $(I^+ - I^-)/(I^+ + I^-)$ is a maximum (>60 %) around $\theta = \pm \alpha$. The spectral weight mapped by $s$ $(p)$ polarization is bright (dark) at $\alpha = 0°$ and dark (bright) at $\theta = 0°$, see Fig. 4(e,f), indicating that the states probed by the 7-eV laser consist of $d_{xy}$ orbitals having odd parity with respect to the reflection at the $x = 0$ and $y = 0$ planes [15–17]. The in-plane orbital character of the initial states may further facilitate the condition of the 2D confinement to be fulfilled.

The case for Cu$_x$Bi$_2$Se$_3$: Bi$_2$Se$_3$ is found to be a topological insulator [18, 19] supporting a single Dirac-cone dispersion on its surface [20–22]. Cu intercalation effectively dopes the system with electron carriers [23, 24]. In the present case, the nominal Cu concentration is $x = 0.17$, and $E_F$ is located 480 meV above $E_D$, as shown in Fig. 5(a). The band dispersion in the $k_xk_y$ plane ($k_x$ is set along $\bar{\Gamma}$-$\bar{M}$ and is parallel to $e_x$ within 3°) changes from nearly isotropic to hexagonal in going away from $E_D$. This can be explained within a 2D $k \cdot p$ Hamiltonian constrained under $C_{3v}$ and time-reversal symmetry [25, 26]:

$$H(k) = v_k(k_x\sigma_y - k_y\sigma_x) + k^2/2m^* + \xi/2(k_x^3 + k_y^3)\sigma_z.$$ (4)

Here, $\xi$ is responsible for the hexagonal warping, $\sigma_i$ is the Pauli matrix, $k_{\pm} = k_x \pm ik_y$, $v_k$ contains a $k^2$-order correction, and $1/m^*$ introduces particle-hole asymmetry. The three-fold pattern observed in the mappings at $E_B \geq 0.54$ eV originates from the bulk valence band, and the faint intensity observed inside the hexagon near $E_F$ is due to the bulk conduction band [24].

In Fig. 5(b), we show $I^D$ at various $E_B$’s. In the vicinity of $E_D$ (at $E_B = 0.42$ and 0.36 eV), we observe nodal lines at $\theta = 0°$ and $\alpha = 0°$. This can be explained by noting that the effective Hamiltonian [eq. (4)] up to second order in $k$ is invariant under mirror operations.
at the $x = 0$ and $y = 0$ planes, and the states therein are 2D, so that the conditions for the horizontal and the vertical nodes are fulfilled. Note that it is the effective Hamiltonian, not the crystal surface, that has the mirror symmetry about the $x = 0$ plane. On the other hand, $I^D$ in the bulk valence-band region at $E_B \geq 0.54$ eV does not show the vertical node since the crystal does not have a vertical mirror plane. It also does not show the horizontal node since the valence-band electronic structure is three-dimensional, even though the crystal has a horizontal mirror plane at $y = 0$.

Very interestingly, the horizontal node in the topological state is gradually distorted in going from $E_D$ to $E_F$, even though the crystal as well as the effective Hamiltonian has horizontal mirror symmetry. This indicates that the topological states lose the condition of 2D confinement at large $k$, most likely reflecting that the topological states around $E_F$ have the character of surface resonance penetrating deep into the bulk rather than being surface states localized on surface layers [27]. This is supported by the fact that the topological states do not merge into the bulk conduction band even at very high electron dopings [24], since this indicates that the topological states around $E_F$ are repelled from the bulk conduction band through hybridization to become a surface resonance. The results thus indicate that the effective Hamiltonian eq. (4) is valid only in the vicinity of $E_D$. The surface-resonance character of the states around $E_F$ may be important to understand the possibly exotic superconductivity of Cu$_x$Bi$_2$Se$_3$ [23, 24, 28, 29] and the recent observation of the topological states away from $E_D$ acquiring out-of-plane spin components [30].

To summarize, we find that the CDAD’s of both SrTiO$_3$:Nb around $E_F$ and Cu-doped Bi$_2$Se$_3$ around $E_D$ exhibit a flower-shaped pattern having horizontal and vertical nodes. The vertical node is explained within a well know geometric effect [5], whereas the horizontal node can be understood using a combination of the geometry and the 2D character of the initial electronic state. The length scale of the 2D confinement of the initial state is set by the de Broglie wavelength of the photoelectron final state. The horizontal node in CDAD can therefore be a measure of the two dimensionality of the electronic states. Practically, it can provide insights into the degree of the surface states being a surface resonance, as demonstrated for the topological state of Cu$_x$Bi$_2$Se$_3$.

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FIG. 1: (Color online) ARPES geometry. The photoelectron distribution is mapped out by rotating the sample. The polarization of the laser is controlled by a wave plate [13].
FIG. 2: (Color online) A bird’s-eye view of photoemission. (a1) Photoemission by a right circularly polarized photon. (a2) and (a3) are mirror reflections of (a1) with respect to the $x = 0$ (incidence) plane and $y = 0$ plane, respectively. $\hat{\Pi}_l$ ($l = x$ or $y$) is the operator for the reflection with respect to the $l = 0$ plane, and we attach a tilde accompanied by $l$ to the reflected states and the reflected vector potentials. (b) A configuration for achieving photoemission into $|\tilde{\Psi}_i^y\rangle$. Note the resemblance of (b) and (a3) up to the direction of the rotation of the vector potentials in the $xy$ plane.
FIG. 3: (Color online) Photoemission from a 2D state into an inverse LEED state. (a) A schematic of the 2D and inverse LEED states. Orange lines show wave fronts that are refracted at the surface. (b) A schematic of the wave functions of the 2D and inverse LEED states.
FIG. 4: (Color online) Spectral intensity distributions ($|E_B| \leq 5$ meV) of SrTiO$_3$:Nb recorded by various polarizations. (a) $(I^+ + I^-)/2$. (b) $I^+$. (c) $I^-$. (d) $I^D$ showing sign change around $\alpha = 0^\circ$ (vertical node) and $\theta = 0^\circ$ (horizontal node). (e) $I^s$. (f) $I^p$. 
FIG. 5: (Color online) CDAD of Cu-doped Bi$_2$Se$_3$. (a) Electronic structure recorded by ARPES on the (111) surface of Cu$_x$Bi$_2$Se$_3$. Here, $I^+ + I^-$ is converted into $k$-space map. The single crystal is grown from the melt. (b) $I^D$ at various $E_B$'s. Also refer to a supplementary movie file.